Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10577554	MOUTEL ET AL.
Examiner	Art Unit

3729

THIEM PHAN

SEARCHED	

Class	Subclass	Date	Examiner
29	854, 829, 874, 877	1/17/11	TP
361	752, 756, 785, 791	"	"
439	79, 131, 377, 660	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search Attached	1/17/11	TP
EAST Keywords:(thick\$4 with (micron or ".mu.m")) and (USB near4 (card or key)) and ((chip or component or IC or die) with (microcircuit or card or board) with (contact or terminal))	а	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
29	854, 829, 874	1/17/11	TP

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